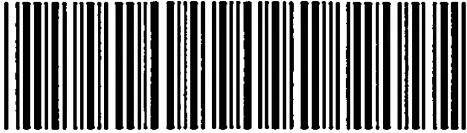


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/682,072	HAMAZAKI ET AL.	
	Examiner	Art Unit	
	Geoffrey Mruk	2853	

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347	14,61-64	7/22/2005	GM

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Text search for ternary, Ta, Si and O	7/22/2005	GM